

## Features

- Temperature ranges
  - Commercial: 0 °C to +70 °C
  - Industrial: -40 °C to +85 °C
  - Automotive-A: -40 °C to +85 °C
  - Automotive-E: -40 °C to +125 °C
- Speed: 70 ns
- Low voltage range: 2.7 V to 3.6 V
- Low active power and standby power
- Easy memory expansion with  $\overline{\text{CE}}$  and  $\overline{\text{OE}}$  features
- TTL compatible inputs and outputs
- Automatic power-down when deselected
- CMOS for optimum speed and power
- Available in standard Pb-free and non Pb-free 28-pin (300-mil) narrow SOIC, 28-pin TSOP-I, and 28-pin reverse TSOP-I packages

## Functional Description

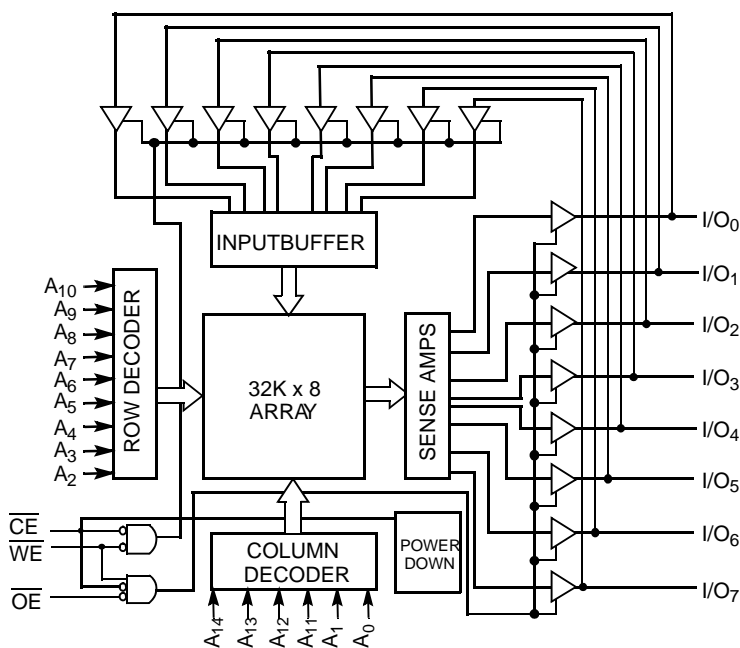
The CY62256VN family is composed of two high performance CMOS static RAM's organized as 32K words by 8 bits. Easy memory expansion is provided by an active LOW chip enable ( $\overline{\text{CE}}$ ) and active LOW output enable ( $\overline{\text{OE}}$ ) and tristate drivers. These devices have an automatic power-down feature, reducing the power consumption by over 99% when deselected.

An active LOW write enable signal ( $\overline{\text{WE}}$ ) controls the writing/reading operation of the memory. When  $\overline{\text{CE}}$  and  $\overline{\text{WE}}$  inputs are both LOW, data on the eight data input/output pins ( $\text{I/O}_0$  through  $\text{I/O}_7$ ) is written into the memory location addressed by the address present on the address pins ( $\text{A}_0$  through  $\text{A}_{14}$ ). Reading the device is accomplished by selecting the device and enabling the outputs,  $\overline{\text{CE}}$  and  $\overline{\text{OE}}$  active LOW, while  $\overline{\text{WE}}$  remains inactive or HIGH. Under these conditions, the contents of the location addressed by the information on address pins are present on the eight data input/output pins.

The input/output pins remain in a high impedance state unless the chip is selected, outputs are enabled, and write enable ( $\overline{\text{WE}}$ ) is HIGH.

For a complete list of related documentation, click [here](#).

## Logic Block Diagram



## Contents

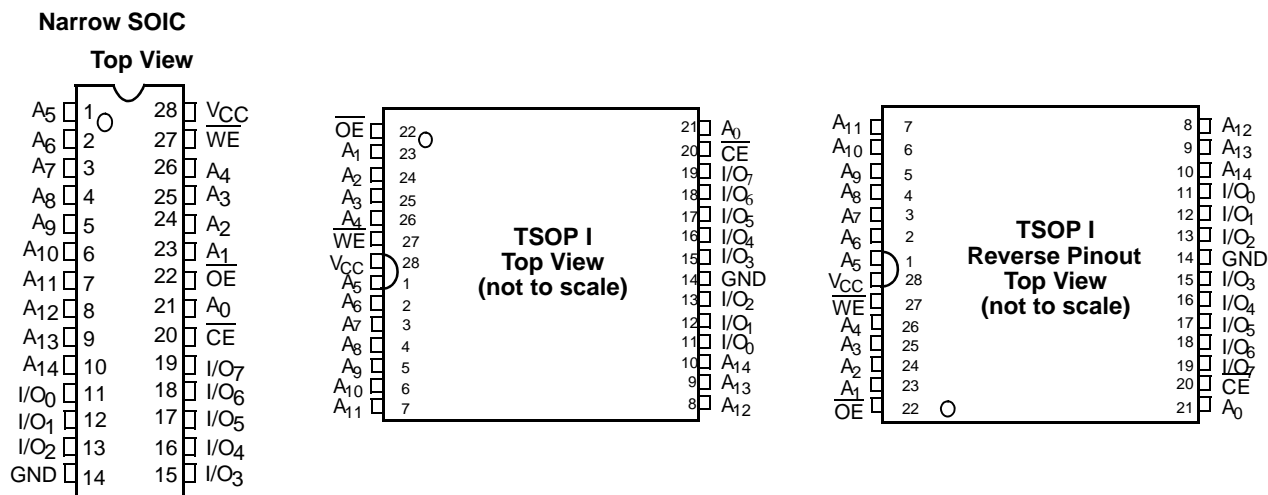
<b>Product Portfolio .....</b>	<b>3</b>	<b>Ordering Information .....</b>	<b>12</b>
<b>Pin Configurations .....</b>	<b>3</b>	Ordering Code Definitions .....	12
<b>Pin Definitions .....</b>	<b>3</b>	<b>Package Diagrams .....</b>	<b>13</b>
<b>Maximum Ratings .....</b>	<b>4</b>	<b>Acronyms .....</b>	<b>15</b>
<b>Operating Range .....</b>	<b>4</b>	<b>Document Conventions .....</b>	<b>15</b>
<b>Electrical Characteristics .....</b>	<b>4</b>	Units of Measure .....	15
<b>Capacitance .....</b>	<b>5</b>	<b>Document History Page .....</b>	<b>16</b>
<b>Thermal Resistance .....</b>	<b>5</b>	<b>Sales, Solutions, and Legal Information .....</b>	<b>17</b>
<b>AC Test Loads and Waveforms .....</b>	<b>5</b>	Worldwide Sales and Design Support .....	17
<b>Data Retention Characteristics .....</b>	<b>6</b>	Products .....	17
<b>Data Retention Waveform .....</b>	<b>6</b>	PSoC® Solutions .....	17
<b>Switching Characteristics .....</b>	<b>7</b>	Cypress Developer Community .....	17
<b>Switching Waveforms .....</b>	<b>8</b>	Technical Support .....	17
<b>Typical DC and AC Characteristics .....</b>	<b>10</b>		
<b>Truth Table .....</b>	<b>11</b>		

## Product Portfolio

Product	Range	V <sub>CC</sub> Range (V)			Power Dissipation			
					Operating, I <sub>CC</sub> (mA)		Standby, I <sub>SB2</sub> (μA)	
		Min	Typ <sup>[1]</sup>	Max	Typ <sup>[1]</sup>	Max	Typ <sup>[1]</sup>	Max
CY62256VNLL	Commercial	2.7	3.0	3.6	11	30	0.1	5
CY62256VNLL	Industrial	2.7	3.0	3.6	11	30	0.1	10
CY62256VNLL	Automotive-A	2.7	3.0	3.6	11	30	0.1	10
CY62256VNLL	Automotive-E	2.7	3.0	3.6	11	30	0.1	130

## Pin Configurations

Figure 1. 28-pin SOIC and 28-pin TSOP I pinouts



## Pin Definitions

Pin Number	Type	Description
1–10, 21, 23–26	Input	<b>A<sub>0</sub>–A<sub>14</sub></b> . Address inputs
11–13, 15–19	Input/Output	<b>I/O<sub>0</sub>–I/O<sub>7</sub></b> . Data lines. Used as input or output lines depending on operation.
27	Input/Control	<b>WE</b> . When selected LOW, a WRITE is conducted. When selected HIGH, a READ is conducted.
20	Input/Control	<b>CE</b> . When LOW, selects the chip. When HIGH, deselects the chip.
22	Input/Control	<b>OE</b> . Output Enable. Controls the direction of the I/O pins. When LOW, the I/O pins behave as outputs. When deasserted HIGH, I/O pins are tristated, and act as input data pins.
14	Ground	<b>GND</b> . Ground for the device
28	Power Supply	<b>VCC</b> . Power supply for the device

### Note

1. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V<sub>CC</sub> = V<sub>CC</sub> Typ, T<sub>A</sub> = 25 °C, and t<sub>AA</sub> = 70 ns.

## Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage temperature ..... -65 °C to +150 °C

Ambient temperature with power applied ..... -55 °C to +125 °C

Supply voltage to ground potential (pin 28 to pin 14) <sup>[2]</sup> ..... -0.5 V to +4.6 V

DC voltage applied to outputs in high Z State <sup>[2]</sup> ..... -0.5 V to  $V_{CC} + 0.5$  V

DC input voltage <sup>[2]</sup> ..... -0.5 V to  $V_{CC} + 0.5$  V

Output current into outputs (LOW) ..... 20 mA

Static discharge voltage

(per MIL-STD-883, method 3015) ..... > 2001 V

Latch-up current ..... > 200 mA

## Operating Range

Device	Range	Ambient Temperature ( $T_A$ ) <sup>[3]</sup>	$V_{CC}$
CY62256VN	Commercial	0 °C to +70 °C	2.7 V to 3.6 V
	Industrial	-40 °C to +85 °C	
	Automotive-A	-40 °C to +85 °C	
	Automotive-E	-40 °C to +125 °C	

## Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions		-70			Unit
				Min	Typ <sup>[4]</sup>	Max	
V <sub>OH</sub>	Output HIGH voltage	I <sub>OH</sub> = −1.0 mA	V <sub>CC</sub> = 2.7 V	2.4	—	—	V
V <sub>OL</sub>	Output LOW voltage	I <sub>OL</sub> = 2.1 mA	V <sub>CC</sub> = 2.7 V	—	—	0.4	V
V <sub>IH</sub>	Input HIGH voltage			2.2	—	V <sub>CC</sub> + 0.3	V
V <sub>IL</sub>	Input LOW voltage			−0.5	—	0.8	V
I <sub>IX</sub>	Input leakage current	GND ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>	Commercial/ Industrial/ Automotive-A	−1	—	+1	μA
			Automotive-E	−10	—	+10	μA
I <sub>OZ</sub>	Output leakage current	GND ≤ V <sub>IN</sub> ≤ V <sub>CC</sub> , Output Disabled	Commercial/ Industrial/ Automotive-A	−1	—	+1	μA
			Automotive-E	−10	—	+10	μA
I <sub>CC</sub>	V <sub>CC</sub> operating supply current	V <sub>CC</sub> = 3.6 V, I <sub>OUT</sub> = 0 mA, f = f <sub>MAX</sub> = 1/t <sub>RC</sub>	All ranges	—	11	30	mA
I <sub>SB1</sub>	Automatic CE power-down current - TTL inputs	V <sub>CC</sub> = 3.6 V, CE ≥ V <sub>IH</sub> , V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub> , f = f <sub>MAX</sub>	All ranges	—	100	300	μA
I <sub>SB2</sub>	Automatic CE power-down current - CMOS inputs	V <sub>CC</sub> = 3.6 V, CE ≥ V <sub>CC</sub> − 0.3 V, V <sub>IN</sub> ≥ V <sub>CC</sub> − 0.3 V or V <sub>IN</sub> ≤ 0.3 V, f = 0	Commercial	—	0.1	5	μA
			Industrial/ Automotive-A	—		10	
			Automotive-E	—		130	

### Notes

2.  $V_{IL}$  (min) = -2.0 V for pulse durations of less than 20 ns.

3.  $T_A$  is the "Instant-On" case temperature.

4. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at  $V_{CC} = V_{CC}$  Typ,  $T_A = 25$  °C, and  $t_{AA} = 70$  ns.

## Capacitance

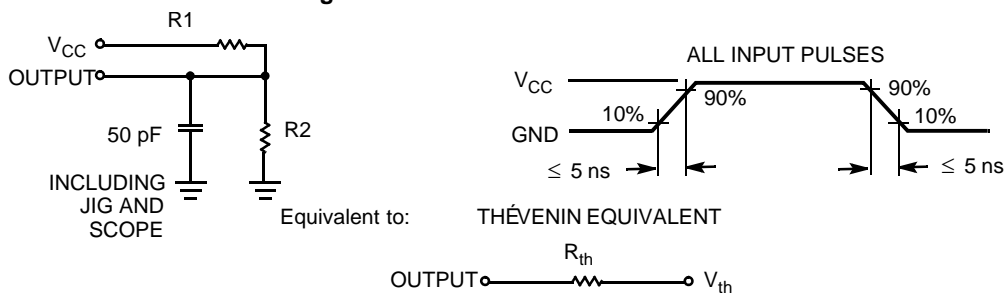
Parameter <sup>[5]</sup>	Description	Test Conditions	Max	Unit
$C_{IN}$	Input capacitance	$T_A = 25^\circ\text{C}$ , $f = 1\text{ MHz}$ , $V_{CC} = 3.0\text{ V}$	6	pF
$C_{OUT}$	Output capacitance		8	pF

## Thermal Resistance

Parameter <sup>[5]</sup>	Description	Test Conditions	SOIC	TSOPI	RTSOPI	Unit
$\theta_{JA}$	Thermal resistance (junction to ambient)	Still air, soldered on a $3 \times 4.5$ inch, two-layer printed circuit board	68.45	87.62	87.62	$^\circ\text{C/W}$
$\theta_{JC}$	Thermal resistance (junction to case)		26.94	23.73	23.73	$^\circ\text{C/W}$

## AC Test Loads and Waveforms

Figure 2. AC Test Loads and Waveforms



Parameter	Value	Units
R1	1100	Ohms
R2	1500	Ohms
RTH	645	Ohms
VTH	1.750	Volts

### Note

5. Tested initially and after any design or process changes that may affect these parameters.

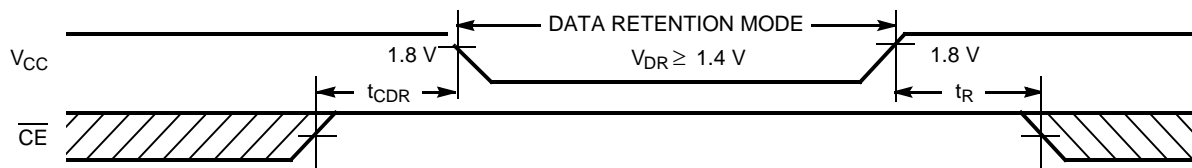
## Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions <sup>[6]</sup>	Min	Typ <sup>[7]</sup>	Max	Unit
$V_{DR}$	$V_{CC}$ for data retention		1.4	–	–	V
$I_{CCDR}$	Data retention current	$V_{CC} = 1.4\text{ V}$ , $\overline{CE} \geq V_{CC} - 0.3\text{ V}$ , $V_{IN} \geq V_{CC} - 0.3\text{ V}$ or $V_{IN} \leq 0.3\text{ V}$	–	0.1	3	$\mu\text{A}$
		Commercial	–		6	
		Industrial/ Automotive-A Automotive-E	–		50	
$t_{CDR}^{[6]}$	Chip deselect to data retention time		0	–	–	ns
$t_R^{[8]}$	Operation recovery time		70	–	–	ns

## Data Retention Waveform

Figure 3. Data Retention Waveform



### Notes

6. No input may exceed  $V_{CC} + 0.3\text{ V}$ .
7. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at  $V_{CC} = V_{CC}\text{ Typ}$ ,  $T_A = 25\text{ }^\circ\text{C}$ , and  $t_{AA} = 70\text{ ns}$ .
8. Tested initially and after any design or process changes that may affect these parameters.

## Switching Characteristics

Over the Operating Range

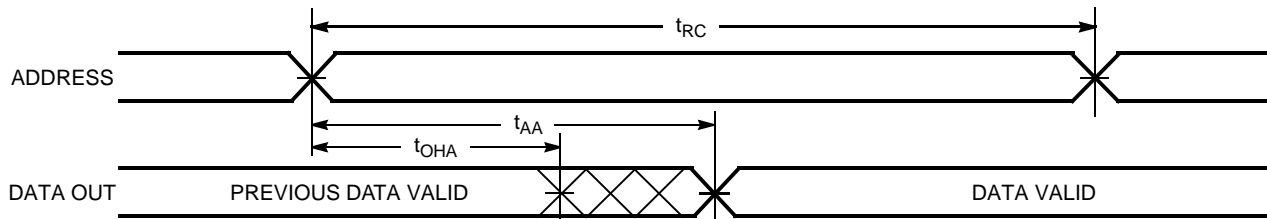
Parameter <sup>[9]</sup>	Description	CY62256VN-70		Unit
		Min	Max	
Read Cycle				
t <sub>RC</sub>	Read cycle time	70	–	ns
t <sub>AA</sub>	Address to data valid	–	70	ns
t <sub>OHA</sub>	Data hold from address change	10	–	ns
t <sub>ACE</sub>	CE LOW to data valid	–	70	ns
t <sub>DOE</sub>	OE LOW to data valid	–	35	ns
t <sub>LZOE</sub>	OE LOW to low Z <sup>[10]</sup>	5	–	ns
t <sub>HZOE</sub>	OE HIGH to high Z <sup>[10, 11]</sup>	–	25	ns
t <sub>LZCE</sub>	CE LOW to low Z <sup>[10]</sup>	10	–	ns
t <sub>HZCE</sub>	CE HIGH to high Z <sup>[10, 11]</sup>	–	25	ns
t <sub>PU</sub>	CE LOW to power-up	0	–	ns
t <sub>PD</sub>	CE HIGH to power-down	–	70	ns
Write Cycle <sup>[12, 13]</sup>				
t <sub>WC</sub>	Write cycle time	70	–	ns
t <sub>SCE</sub>	CE LOW to write end	60	–	ns
t <sub>AW</sub>	Address setup to write end	60	–	ns
t <sub>HA</sub>	Address hold from write end	0	–	ns
t <sub>SA</sub>	Address setup to write start	0	–	ns
t <sub>PWE</sub>	WE pulse width	50	–	ns
t <sub>SD</sub>	Data setup to write end	30	–	ns
t <sub>HD</sub>	Data hold from write end	0	–	ns
t <sub>HZWE</sub>	WE LOW to high Z <sup>[10, 11]</sup>	–	25	ns
t <sub>LZWE</sub>	WE HIGH to low Z <sup>[10]</sup>	10	–	ns

### Notes

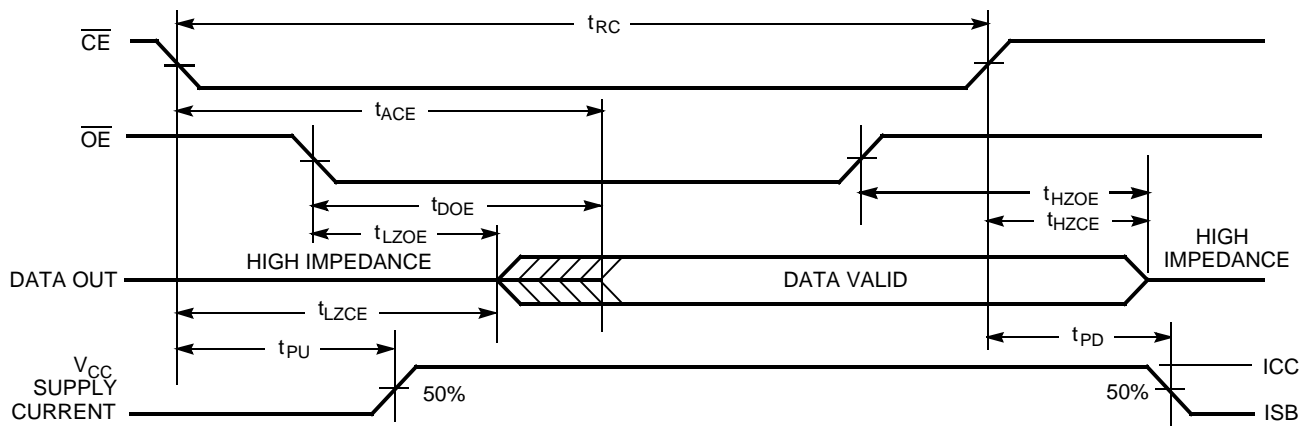
9. Test conditions assume signal transition time of 5 ns or less timing reference levels of  $V_{CC}/2$ , input pulse levels of 0 to  $V_{CC}$ , and output loading of the specified  $I_{OL}/I_{OH}$  and 100-pF load capacitance.
10. At any temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any device.
11.  $t_{HZOE}$ ,  $t_{HZCE}$ , and  $t_{HZWE}$  are specified with  $C_L = 5$  pF as in (b) of AC Test Loads. Transition is measured  $\pm 200$  mV from steady-state voltage.
12. The internal write time of the memory is defined by the overlap of  $\overline{CE}$  LOW and  $\overline{WE}$  LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.
13. The minimum write cycle time for Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .

## Switching Waveforms

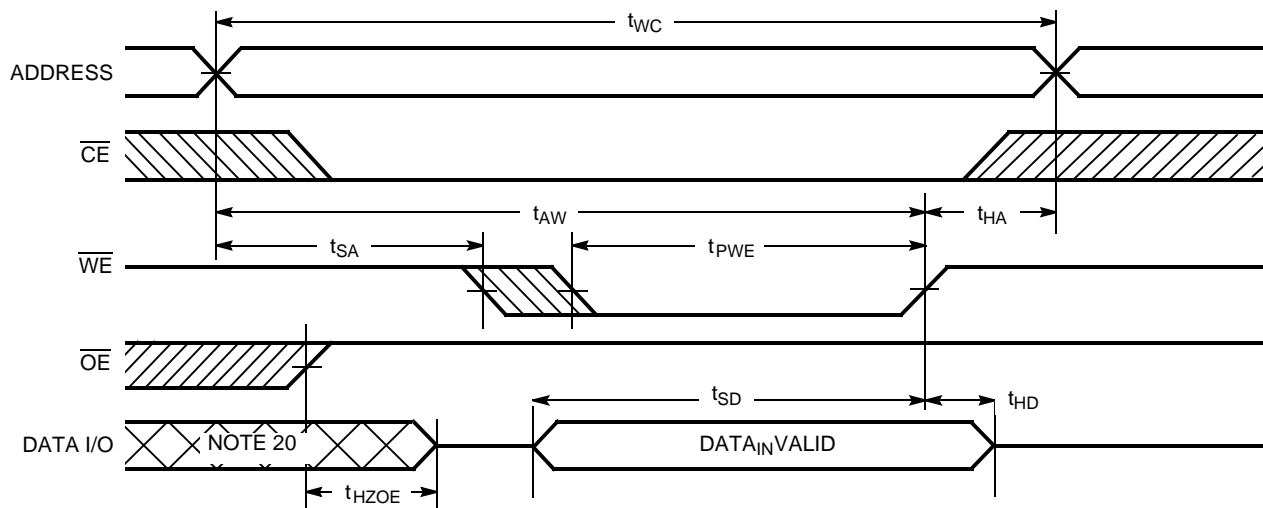
**Figure 4. Read Cycle No. 1** [14, 15]



**Figure 5. Read Cycle No. 2** [15, 16]



**Figure 6. Write Cycle No. 1 ( $\overline{WE}$  Controlled)** [17, 18, 19]



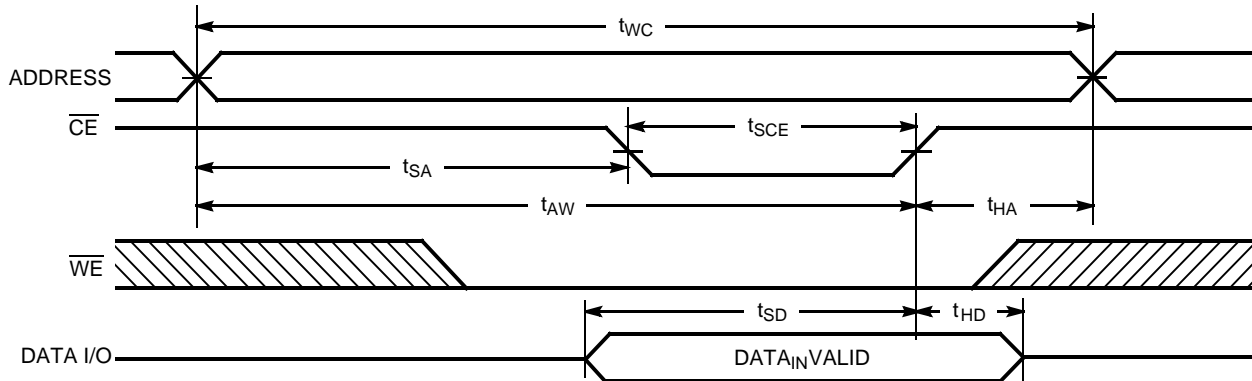
### Notes

14. Device is continuously selected.  $\overline{OE}$ ,  $\overline{CE} = V_{IL}$ .
15.  $\overline{WE}$  is HIGH for read cycle.
16. Address valid prior to or coincident with  $\overline{CE}$  transition LOW.
17. The internal write time of the memory is defined by the overlap of  $\overline{CE}$  LOW and  $\overline{WE}$  LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.
18. Data I/O is high impedance if  $\overline{OE} = V_{IH}$ .
19. If  $\overline{CE}$  goes HIGH simultaneously with  $\overline{WE}$  HIGH, the output remains in a high impedance state.
20. During this period, the I/Os are in output state and input signals should not be applied.

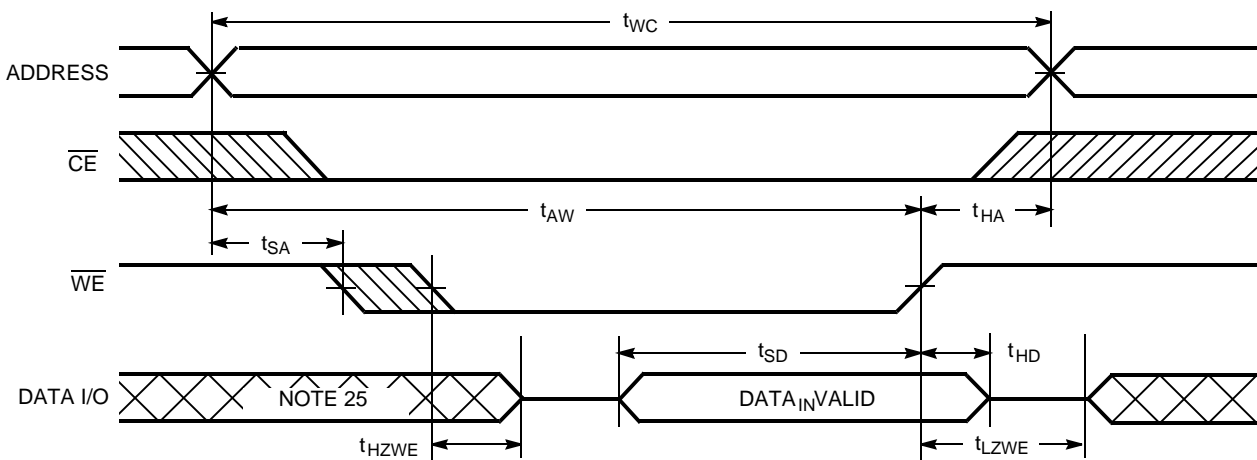


## Switching Waveforms (continued)

**Figure 7. Write Cycle No. 2 ( $\overline{\text{CE}}$  Controlled) [21, 22, 23]**



**Figure 8. Write Cycle No. 3 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  LOW) [23, 24]**



### Notes

21. The internal write time of the memory is defined by the overlap of  $\overline{\text{CE}}$  LOW and  $\overline{\text{WE}}$  LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.

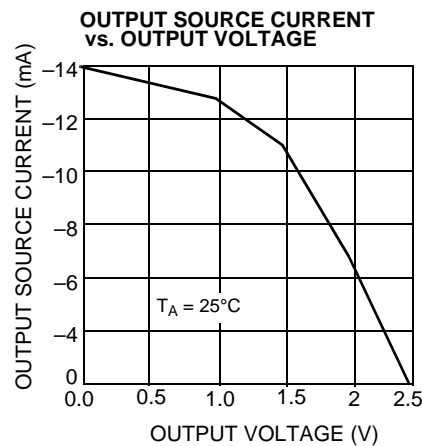
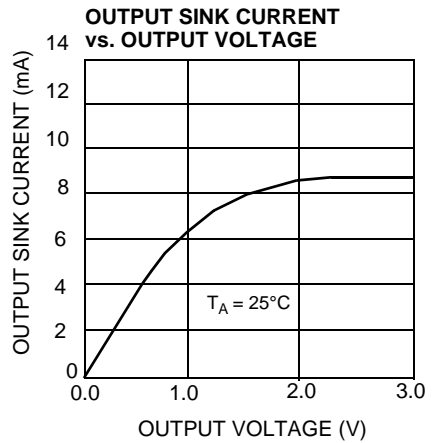
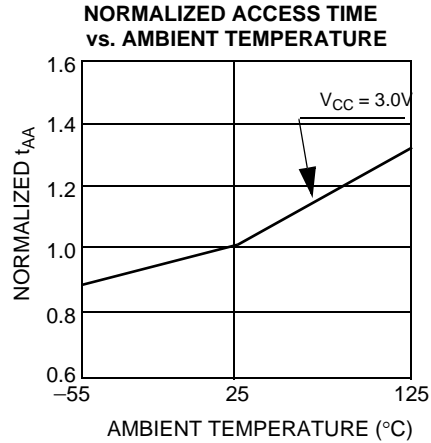
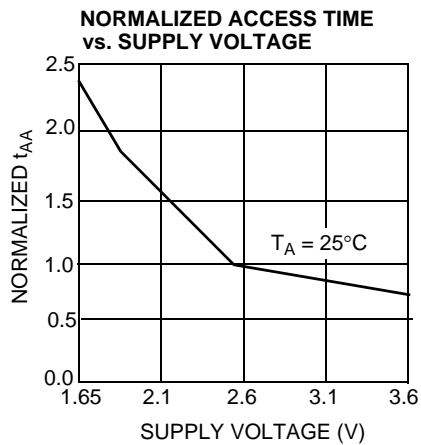
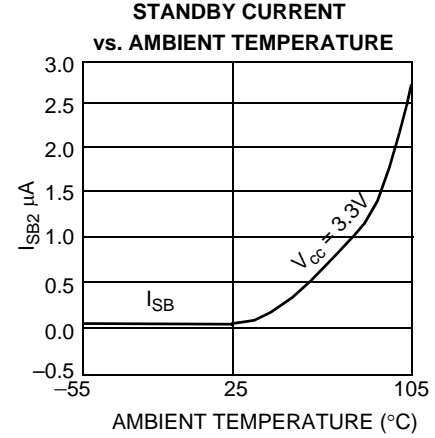
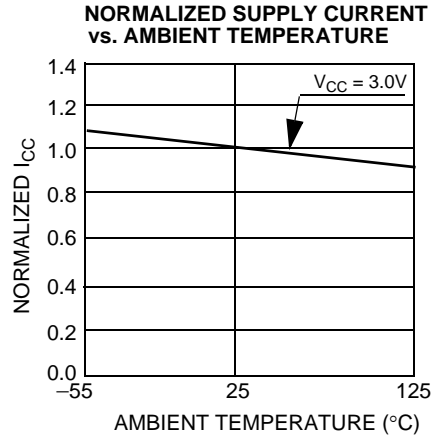
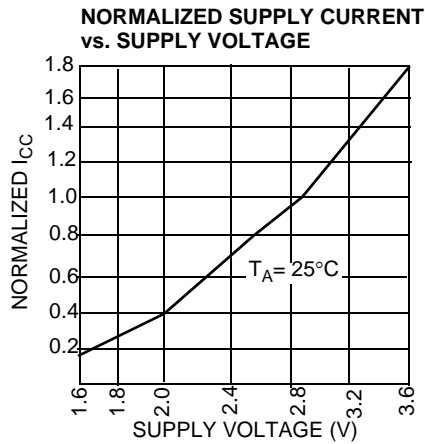
22. Data I/O is high impedance if  $\text{OE} = V_{IH}$ .

23. If  $\overline{\text{CE}}$  goes HIGH simultaneously with  $\overline{\text{WE}}$  HIGH, the output remains in a high impedance state.

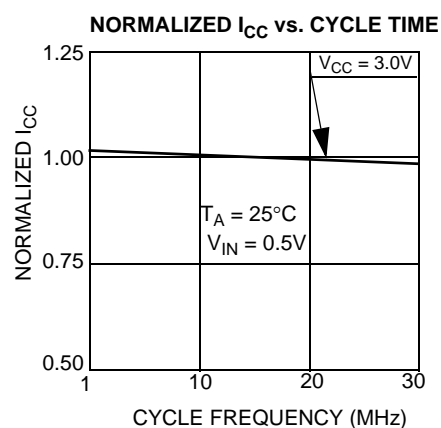
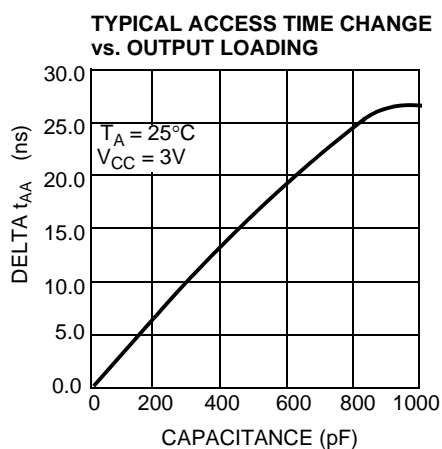
24. The minimum write cycle time for write cycle No. 3 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .

25. During this period, the I/Os are in output state and input signals should not be applied.

## Typical DC and AC Characteristics



## Typical DC and AC Characteristics *(continued)*



## Truth Table

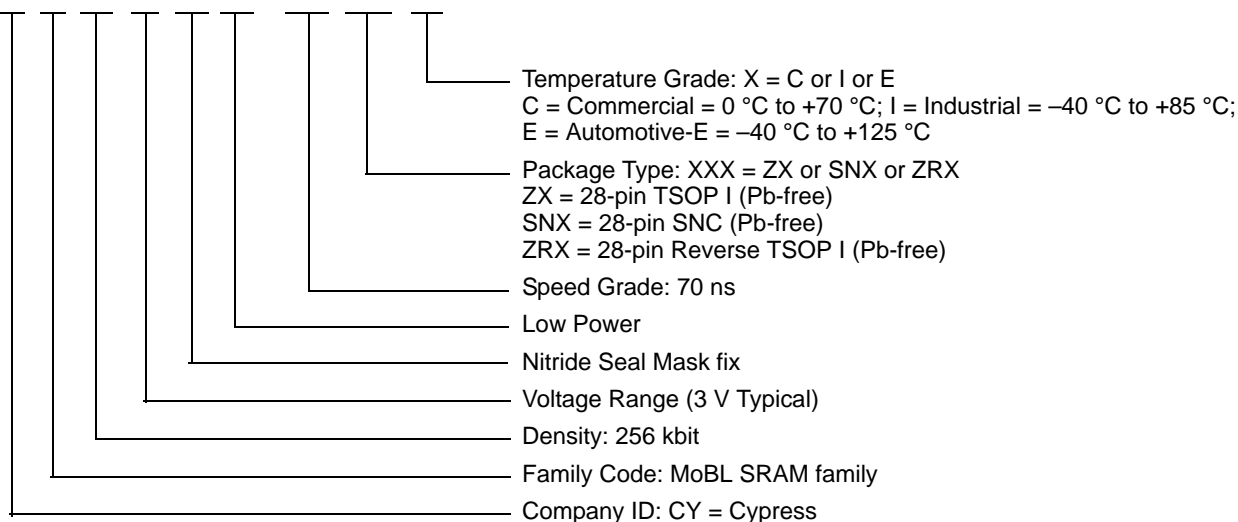
$\overline{CE}$	$\overline{WE}$	$\overline{OE}$	Inputs/Outputs	Mode	Power
H	X	X	High Z	Deselect/power-down	Standby ( $I_{SB}$ )
L	H	L	Data out	Read	Active ( $I_{CC}$ )
L	L	X	Data in	Write	Active ( $I_{CC}$ )
L	H	H	High Z	Deselect, output disabled	Active ( $I_{CC}$ )

## Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
70	CY62256VNLL-70ZXC	51-85071	28-pin TSOP I (Pb-free)	Commercial
	CY62256VNLL-70SNXI	51-85092	28-pin SNC (300 Mils) Narrow Body (Pb-free)	Industrial
	CY62256VNLL-70ZXI	51-85071	28-pin TSOP I (Pb-free)	
	CY62256VNLL-70ZRXI	51-85074	28-pin Reverse TSOP I (Pb-free)	
	CY62256VNLL-70SNXE	51-85092	28-pin SNC (300 Mils) Narrow Body (Pb-free)	Automotive-E
	CY62256VNLL-70ZXE	51-85071	28-pin TSOP I (Pb-free)	

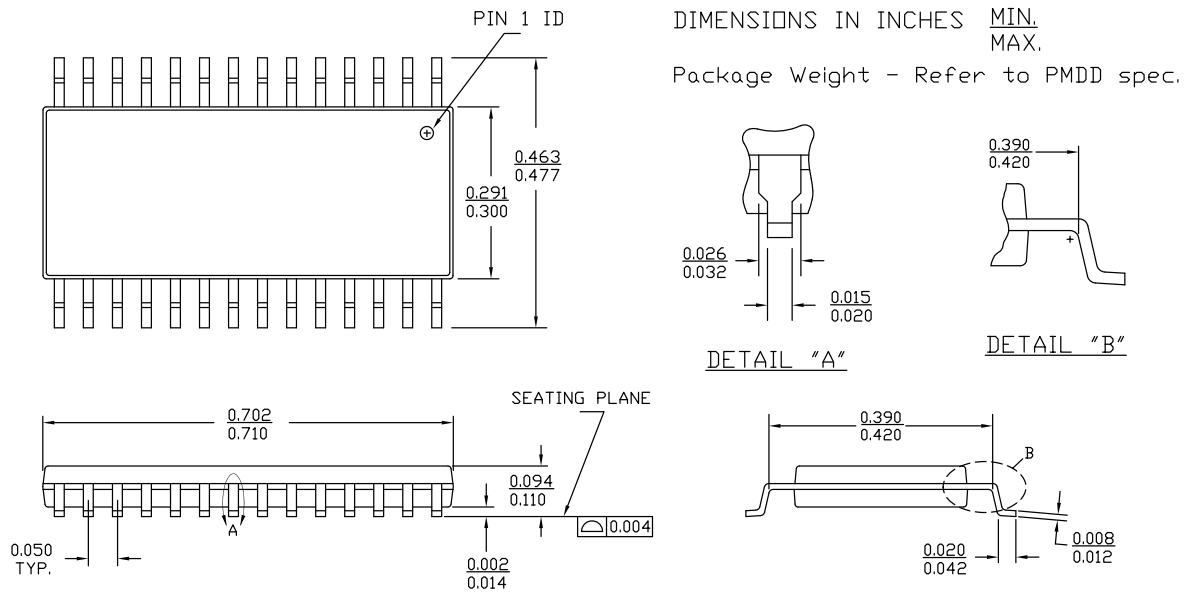
## Ordering Code Definitions

CY 62 256 V N LL - 70 XXX X



## Package Diagrams

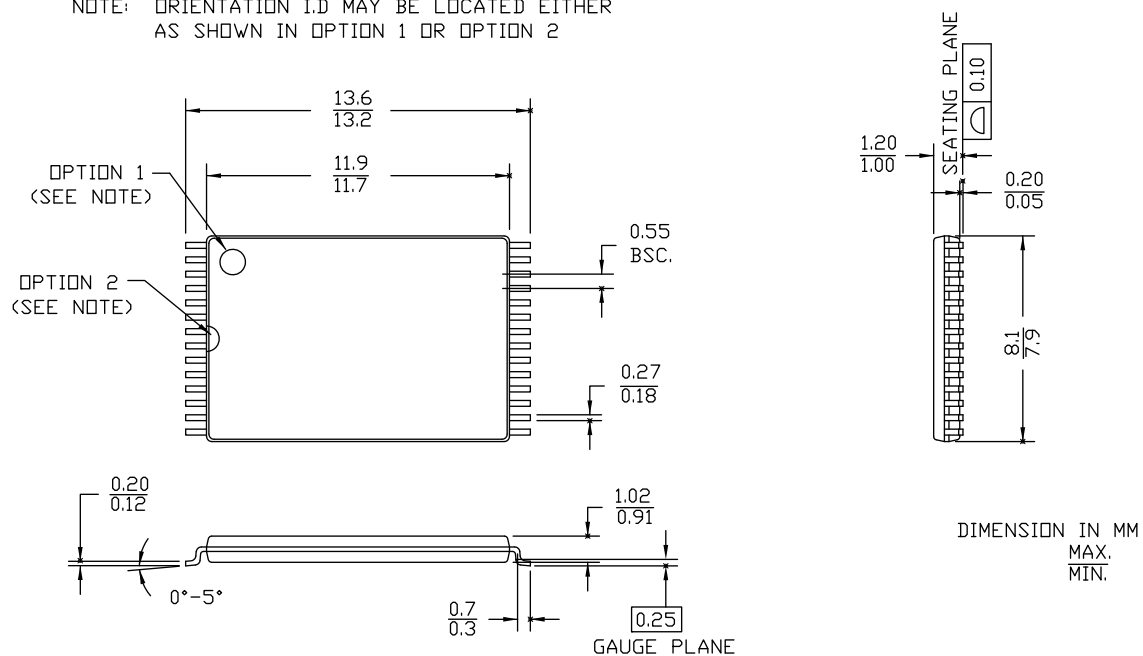
**Figure 9. 28-pin SNC (300 Mils) SN28.3 (Narrow Body) Package Outline, 51-85092**



51-85092 \*E

**Figure 10. 28-pin TSOP 1 (8 × 13.4 × 1.2 mm) Z28 (Standard) Package Outline, 51-85071**

NOTE: ORIENTATION I.D. MAY BE LOCATED EITHER AS SHOWN IN OPTION 1 OR OPTION 2

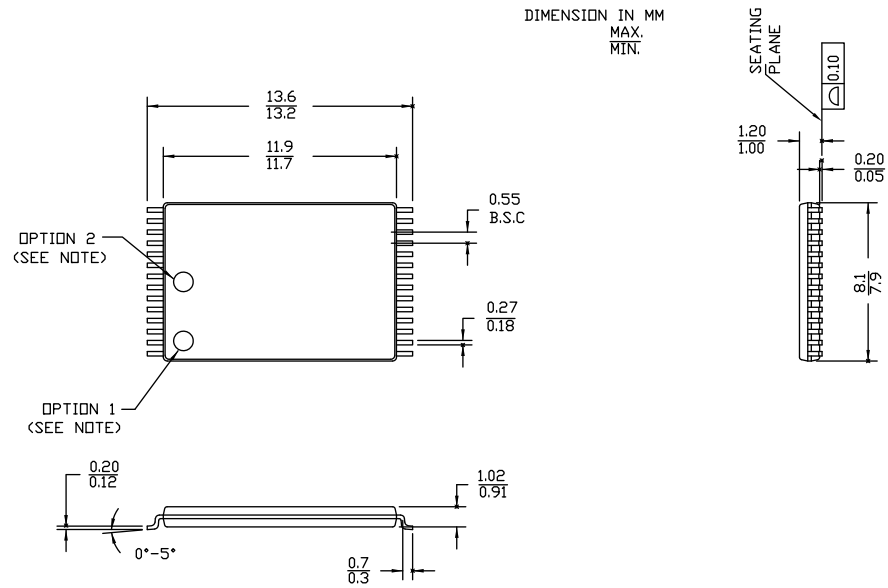


51-85071 \*J

## Package Diagrams

**Figure 11. 28-pin TSOP I (8 × 13.4 mm) Package Outline - Reverse, 51-85074**

NOTE: ORIENTATION I.D. MAY BE LOCATED EITHER  
AS SHOWN IN OPTION 1 OR OPTION 2



51-85074 \*H

## Acronyms

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
I/O	Input/Output
SRAM	Static Random Access Memory
TSOP	Thin Small Outline Package
VFBGA	Very Fine-Pitch Ball Grid Array

## Document Conventions

### Units of Measure

Symbol	Unit of Measure
°C	degree Celsius
μA	microampere
mA	milliampere
MHz	megahertz
ns	nanosecond
Ω	ohm
pF	picofarad
V	volt
W	watt

## Document History Page

Document Title: CY62256VN, 256-Kbit (32 K × 8) Static RAM Document Number: 001-06512				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	426504	NXR	See ECN	New data sheet
*A	488954	NXR	See ECN	Added Automotive product Updated ordering Information table
*B	2769239	VKN / AESA	09/25/09	Corrected V <sub>IL</sub> description in the Electrical Characteristics table
*C	2901521	AJU	03/30/2010	Removed inactive parts from Ordering Information. Updated Package Diagram.
*D	3119519	AJU	01/04/2011	Updated <a href="#">Ordering Information</a> . Added <a href="#">Ordering Code Definitions</a> .
*E	3329873	RAME	07/27/11	Updated template and styles according to current Cypress standards. Added acronyms and units. Removed reference to AN1064 SRAM system guidelines. Updated operation recovery time parameter under <a href="#">Data Retention Characteristics on page 6</a> .
*F	4122787	VINI	09/13/2013	Updated <a href="#">Package Diagrams</a> : spec 51-85092 – Changed revision from *C to *E. Updated in new template. Completing Sunset Review.
*G	4525875	VINI	10/06/2014	Updated <a href="#">Maximum Ratings</a> : Referred Note 2 in “Supply voltage to ground potential (pin 28 to pin 14)”. Updated <a href="#">Package Diagrams</a> : spec 51-85071 – Changed revision from *I to *J. spec 51-85074 – Changed revision from *G to *H. Completing Sunset Review.
*H	4576406	VINI	01/16/2015	Added related documentation hyperlink in page 1. Added Note 13 in <a href="#">Switching Characteristics</a> . Added note reference 13 in the <a href="#">Switching Characteristics</a> table.



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